


Search Notes		Application/Control No.	Applicant(s)/Patent under Reexamination	
		10/817,510	DEPUE ET AL.	
		Examiner	Art Unit	
		José V. Chen	3637	

SEARCHED			
Class	Subclass	Date	Examiner
106	45	1/8/66	SV
	45		
	42		
	48		
229	480		
<del>UPDATER 5/3/66 SV</del>			
<del>UPDATER 6/1/66 SV</del>			
<del>UPDATER 11/14/66 SV</del>			
<del>UPDATER 1/30/67 SV</del>			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Feedback Control	1/8/66	SV
Proc Art		
<del>UPDATER 5/3/66 SV</del>		
<del>UPDATER 6/1/66 SV</del>		
UPDATER	11/14/66	SV
UPDATER	1/30/67	SV